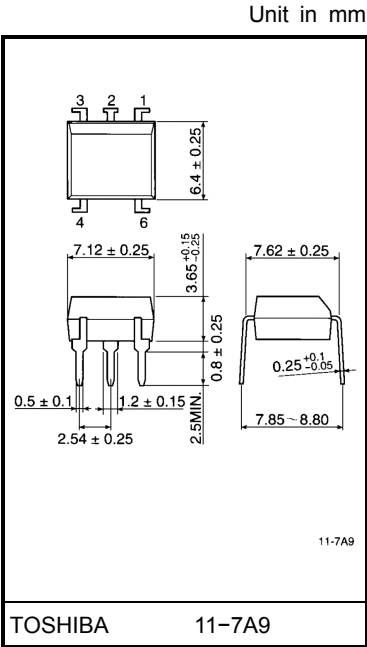


TLP591B

Telecommunication
Programmable Controllers
MOS Gate Driver
MOS FET Gate Driver

The TOSHIBA TLP591B consists of an aluminum gallium arsenide infrared emitting diode optically coupled to a series connected photo-diode array in a six lead plastic DIP package.
TLP591B is suitable for MOS FET gate driver.
TLP591B has an internal shunt resistor to optimize switching speed.

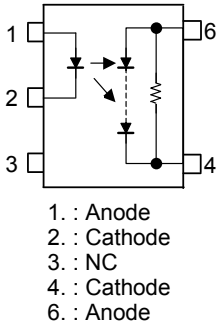
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Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
LED	Forward current	IF	50	mA
	Forward current derating (Ta ≥ 25°C)	ΔIF /°C	-0.5	mA /°C
	Pulse forward current (100μs pulse, 100pps)	IFP	1	A
	Reverse voltage	VR	3	V
	Junction temperature	Tj	125	°C
Detector	Forward current	IFD	50	μA
	Reverse voltage	VRD	10	V
	Junction temperature	Tj	125	°C
Storage temperature range		Tstg	-55~125	°C
Operating temperature range		Topr	-40~85	°C
Lead soldering temperature (10 sec.)		Tsol	260	°C
Isolation voltage (AC, 1 min., R.H.≤ 60%) (Note 1)		BVS	2500	Vrms

Pin Configuration (top view)



(Note 1) Device considered a two terminal device: Pins 1, 2 and 3 shorted together, and pins 4 and 6 shorted together.

Recommended Operating Conditions

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Forward current	I_F	—	20	25	mA
Operating temperature	T_{opr}	-25	—	85	°C

Individual Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit
LED	Forward voltage	V_F	$I_F = 10\text{ mA}$	1.2	1.4	1.7	V
	Reverse current	I_R	$V_R = 3\text{ V}$	—	—	10	μA
	Capacitance	C_T	$V = 0, f = 1\text{ MHz}$	—	30	60	pF
Detector	Forward voltage	V_{FD}	$I_{FD} = 10\text{ }\mu\text{A}$	—	7	—	V
	Reverse current	I_{RD}	$V_{RD} = 10\text{ V}$	—	7	—	μA
	Capacitance (anode to cathode)	C_{TD}	$V = 0, f = 1\text{ MHz}$	—	—	—	pF

Coupled Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Open voltage	V_{OC}	$I_F = 20\text{ mA}$	7	8	—	V
Short Current	I_{SC}	$I_F = 20\text{ mA}$	24	40	—	μA

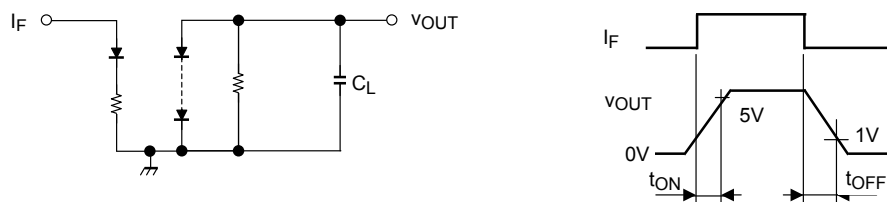
Isolation Characteristics ($T_a = 25^\circ\text{C}$)

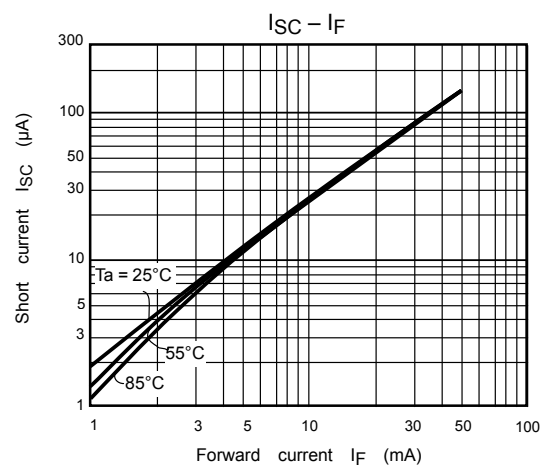
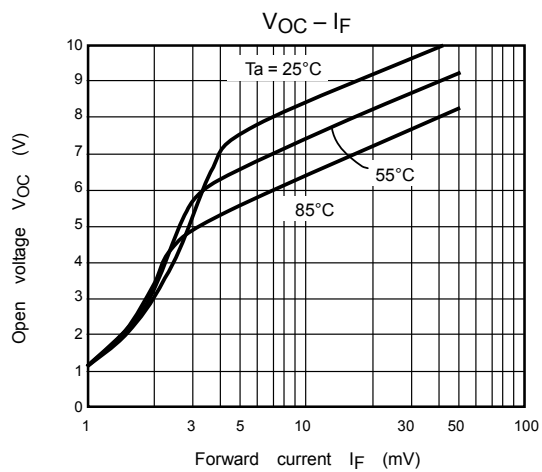
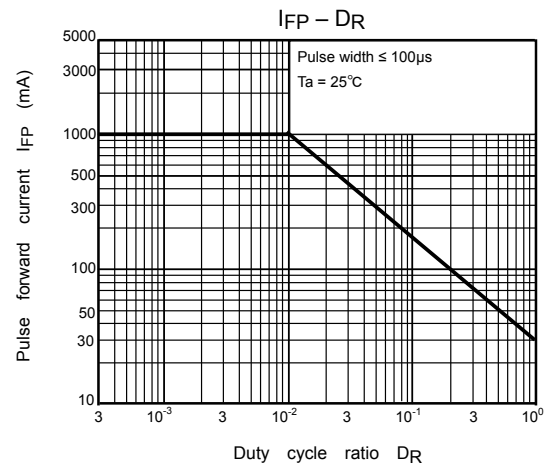
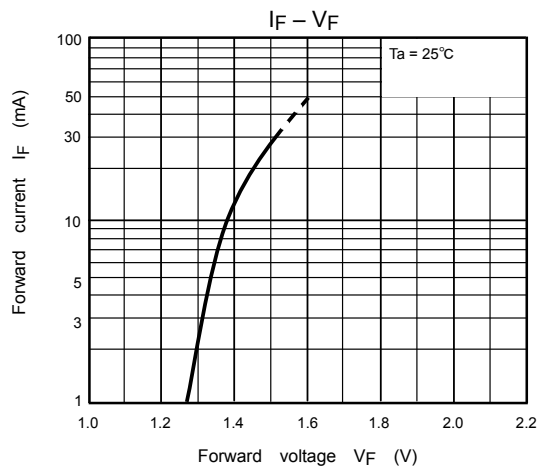
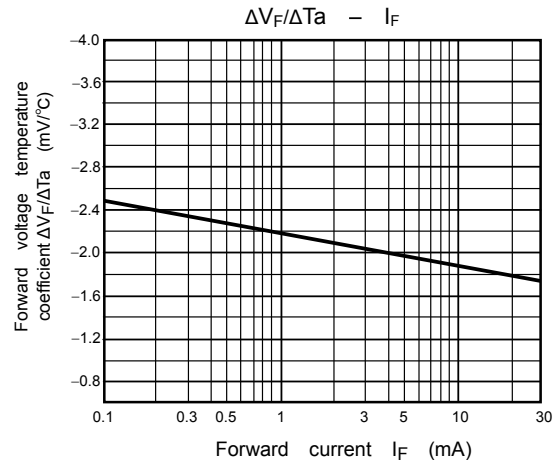
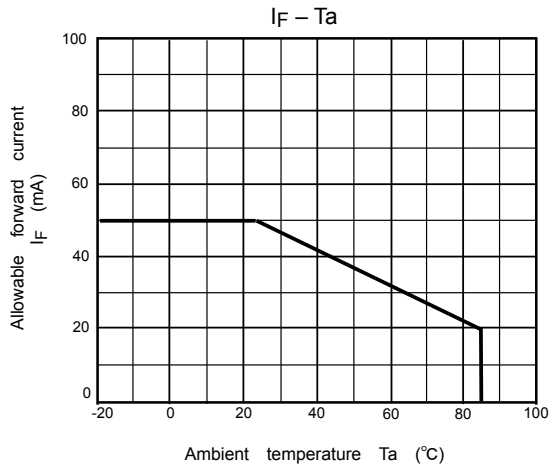
Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Capacitance (input to output)	C_S	$V_S = 0, f = 1\text{ MHz}$	—	0.8	—	pF
Isolation resistance	R_S	$V_S = 500\text{ V}$	5×10^{10}	10^{14}	—	
Isolation voltage	BV_S	AC, 1 minute	2500	—	—	Vrms
		AC, 1 second, in oil	—	5000	—	
		DC, 1 minute, in oil	—	5000	—	Vdc

Switching Characteristics ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Turn-on time	t_{on}	$I_F = 20\text{ mA}, C_L = 1000\text{ pF}$ (Fig. 1)	—	0.2	—	ms
Turn-off time	t_{off}		—	3	—	ms

Fig. 1 Switching time test circuit





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20070701-EN

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